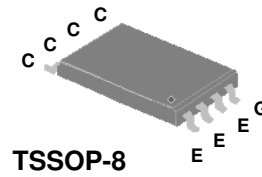




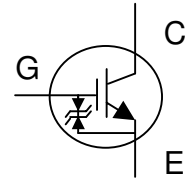
**Insulated Gate Bipolar Power Transistor**

- High Input Impedance
- High Peak Current Capability
- Low Gate Drive
- Strobe Flash Applications
- RoHS-compliant, halogen-free package



TSSOP-8

$V_{CE}$	400V
$I_{CP}$	150A



**Absolute Maximum Ratings**

Symbol	Parameter	Rating	Units
$V_{CE}$	Collector-Emitter Voltage	400	V
$V_{GEP}$	Peak Gate-Emitter Voltage	$\pm 6$	V
$I_{CP}$	Pulsed Collector Current	150	A
$P_D$ at $T_A=25^\circ C^1$	Maximum Power Dissipation	1	W
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ C$
$T_J$	Junction Temperature Range	-55 to 150	$^\circ C$

**Electrical Specifications at  $T_J=25^\circ C$  (unless otherwise specified)**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$I_{GE}$	Gate-Emitter Leakage Current	$V_{GE}=\pm 6V, V_{CE}=0V$	-	-	$\pm 10$	$\mu A$
$I_{CES}$	Collector-Emitter Leakage Current	$V_{CE}=400V, V_{GE}=0V$	-	-	10	$\mu A$
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$V_{GE}=2.5V, I_{CP}=150A$ (Pulsed)	-	5.5	9	V
$V_{GE(th)}$	Gate Threshold Voltage	$V_{CE}=V_{GE}, I_C=250\mu A$	0.3	-	1.2	V
$Q_g$	Total Gate Charge	$I_C=40A$	-	76	130	nC
$Q_{ge}$	Gate-Emitter Charge	$V_{CE}=200V$	-	4	-	nC
$Q_{gc}$	Gate-Collector Charge	$V_{GE}=4V$	-	26	-	nC
$t_{d(on)}$	Turn-on Delay Time	$V_{CC}=320V$	-	220	-	ns
$t_r$	Rise Time	$I_C=160A$	-	800	-	ns
$t_{d(off)}$	Turn-off Delay Time	$R_G=10\Omega$	-	1.6	-	$\mu s$
$t_f$	Fall Time	$V_{GE}=4V$	-	1.5	-	$\mu s$
$C_{ies}$	Input Capacitance	$V_{GE}=0V$	-	4485	8240	pF
$C_{oes}$	Output Capacitance	$V_{CE}=30V$	-	44	-	pF
$C_{res}$	Reverse Transfer Capacitance	$f=1.0MHz$	-	40	-	pF
$R_{thJA}^1$	Thermal Resistance Junction-Ambient		-	-	125	$^\circ C/W$

**Notes:**

1.Surface mounted on 1 in<sup>2</sup> copper pad of FR4 board

**Ordering Information**

**AP28G40GEO-HF-3TR** : in RoHS-compliant halogen-free TSSOP-8 shipped on tape and reel (3000 pcs/reel)



## Typical Electrical Characteristics

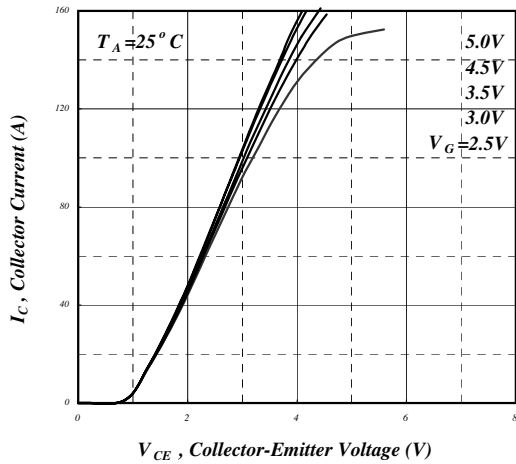


Fig 1. Typical Output Characteristics

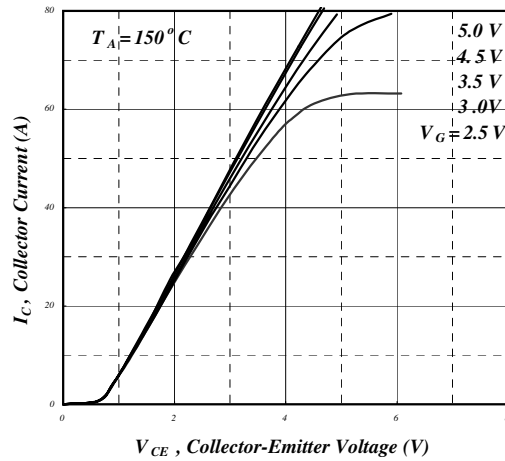


Fig 2. Typical Output Characteristics

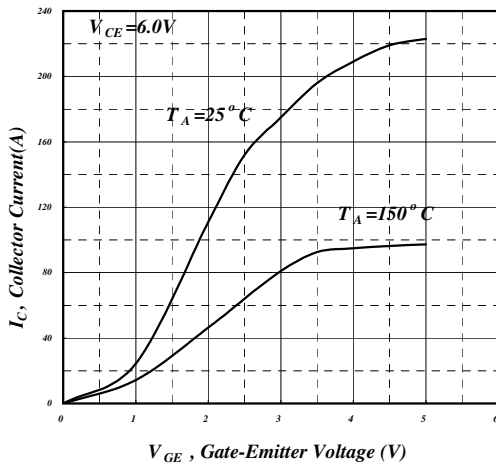


Fig 3. Typical Saturation Voltage Characteristics

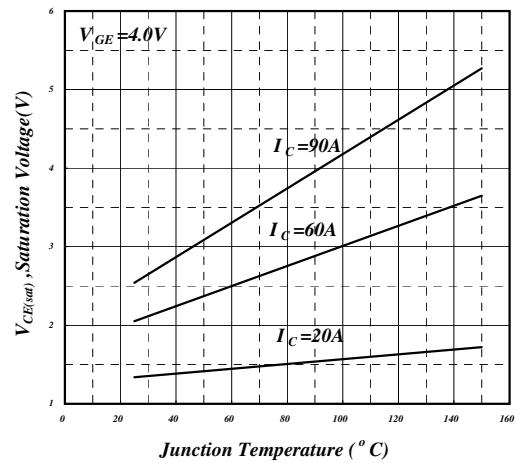


Fig 4. Collector-Emitter Saturation Voltage vs. Junction Temperature

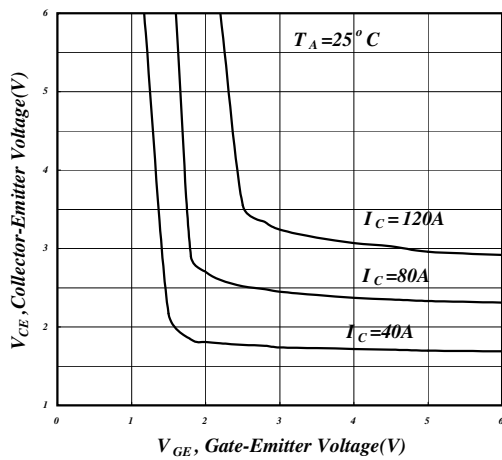


Fig 5. Collector Current vs. Gate-Emitter Voltage

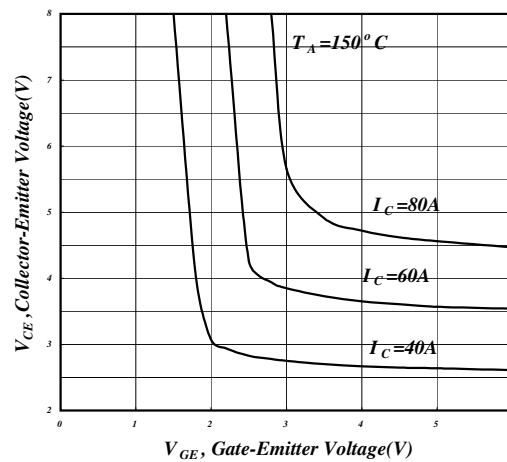


Fig 6. Collector Current vs. Gate-Emitter Voltage



Typical Electrical Characteristics (cont.)

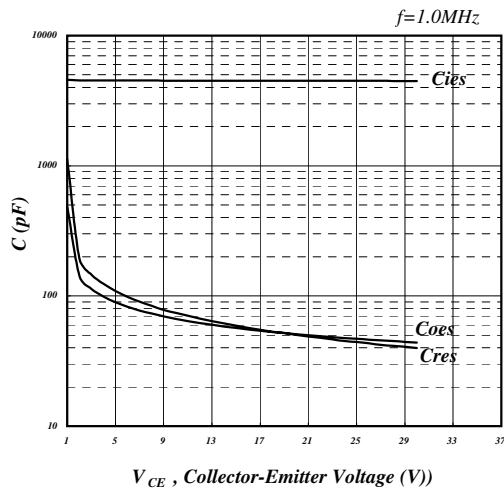


Fig 7. Typical Capacitance Characteristics

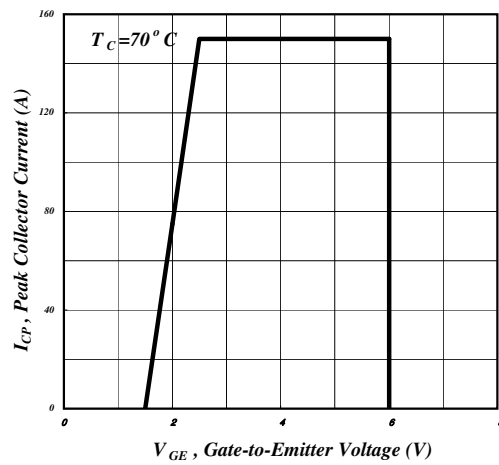


Fig 8. Maximum Pulse Collector Current

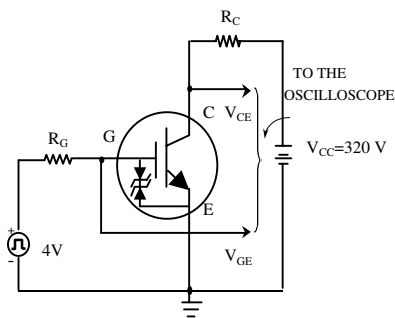


Fig 9. Switching Time Test Circuit

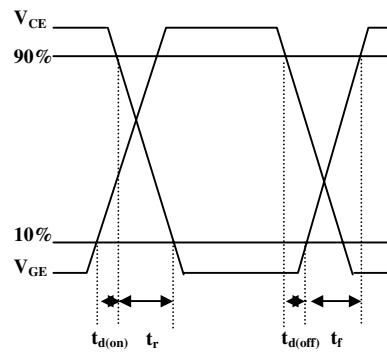


Fig 10. Switching Time Waveform

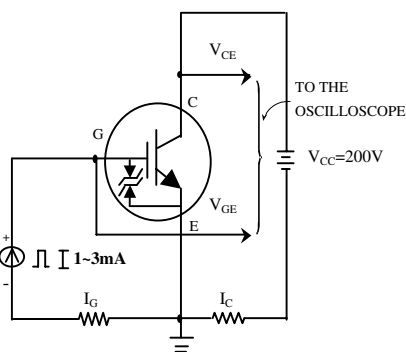


Fig 11. Gate Charge Test Circuit

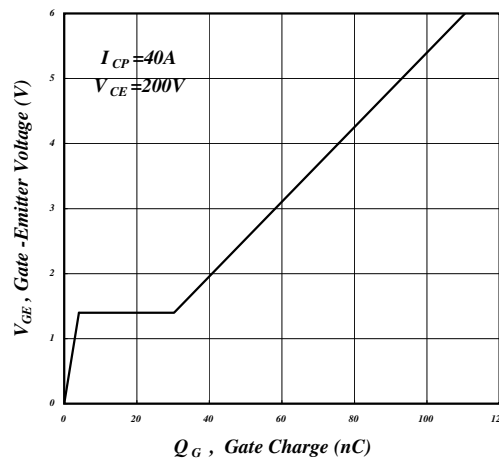
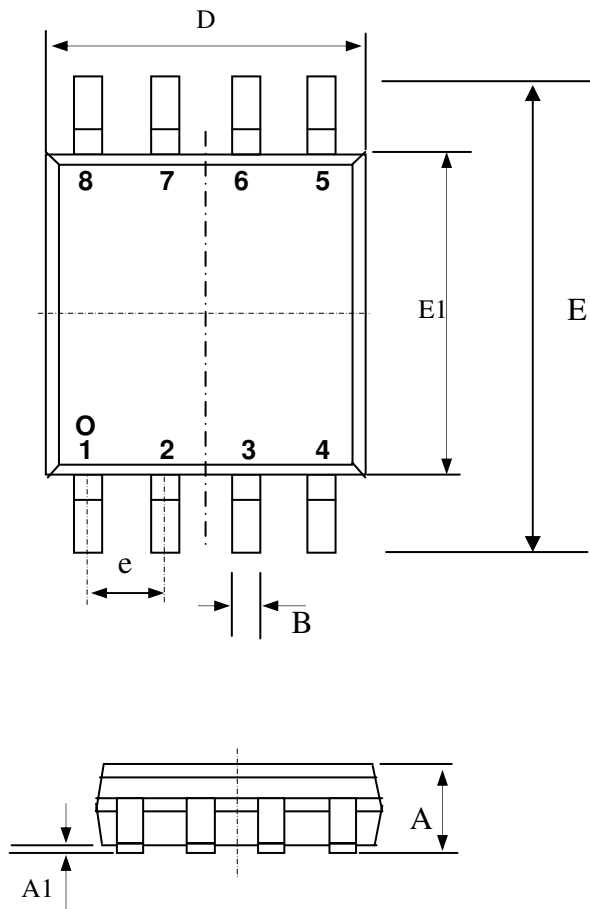


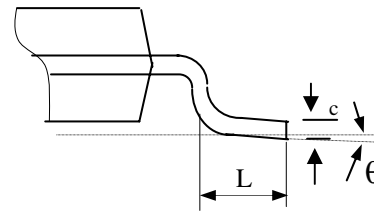
Fig 12. Gate Charge Waveform



**Package Dimensions: TSSOP-8**

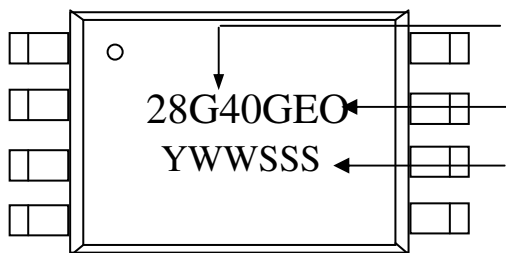


SYMBOLS	Millimeters		
	MIN	NOM	MAX
A	---	---	1.20
A1	0.05	---	0.15
B	0.19	---	0.30
C	---	0.127	---
D	2.90	3.00	3.10
E	6.20	6.40	6.60
E1	4.30	4.40	4.50
L	0.45	0.60	0.75
e	0.65 REF.		
θ	0°	---	8°



1. All dimensions are in millimeters.
2. Dimensions do not include mold protrusions.

**Marking Information:**



Product: AP28G40  
 28G40GEO ← GEO = RoHS-compliant TSSOP-8 with Gate ESD protection  
 YWWSSS ← YWWSSS = Date/lot code  
 YWW = Year and work week of manufacture.  
 SSS = Lot code information.